

Search Notes

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Examiner

HOAN C. NGUYEN

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	139	11/28/2005	CHN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	11/28/2005	CHN